



Sheet 1 of 1

FORM PTO-1449 U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. SJO920020018US1	SERIAL NO. 10/627,396
SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT BY APPLICANT		APPLICANT Jeffrey S. Lille et al.	
		FILING DATE July 24, 2003	GROUP <del>2627</del>

#### U. S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
B	AA	5,986,978	11/16/1999	Rottmayer et al.	369	13	
	AB	6,493,183 B1	12/10/2002	Kasiraj et al.	360	126	
	AC	US 2003/0021191 A1	01/30/2003	Hsu et al.	369	13.17	
	AD	US 2003/0043699 A1	03/06/2003	Isshiki et al.	369	13.33	
B	AE	US 2003/0128633 A1	07/10/2003	Batra et al.	369	13.32	
	AF						
	AG						
	AH						

#### FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	NAME	CLASS	SUBCLASS	TRANSLATION YES NO
B	AI	JP57113406A	07/14/1982	JP	Ricoh Co Ltd			
B	AJ	JP02037501 A	02/07/1990	JP	Hitachi Ltd			
B	AK	JP2002133608 A	05/10/2002	JP	Toshiba Corp			

#### OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

	AL		
	AM		

EXAMINER <u>B. Small</u>	DATE CONSIDERED <u>5/2/06</u>
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EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.
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FORM PTO-1449 U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. SJO920020118US1	SERIAL NO. <i>Unsigned 10/27/396</i>
INFORMATION DISCLOSURE STATEMENT BY APPLICANT		APPLICANT Lille et al.	
		FILING DATE <i>Herewith 7/24/03</i>	GROUP <i>Unsigned 2627</i>

## U. S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
<i>Bn</i>	AA	US 6,392,832 B1	5/21/2002	Oshiki et al.	360	59	
	AB	US 2002/0057511 A1	5/16/2002	Kikitsu et al.	360	59	
	AC	US 6,367,924 B1	4/9/2002	Sato et al.	347	105	
	AD	US 2002/0008930 A1	1/24/2002	Shimoda et al.	360	59	
	AE	US 6,333,827 B1	12/25/2001	Hamamoto et al.	360	59	
	AF	US 6,317,280 B1	11/13/2001	Nakajima et al.	360	59	
	AG	US 2001/0006435 A1	7/5/2001	Ichihara et al.	360	55	
	AH	US 6,233,206 B1	5/15/2001	Hamann et al.	369	13	
	AI	6,088,204	7/11/2000	Farrow et al.	360	327	
<i>Bn</i>	AJ	6,011,664	1/4/2000	Kryder et al.	360	59	
	AK						

## FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	NAME	CLASS	SUBCLASS	TRANSLATION YES NO
	AL							
	AM							
	AN							
	AO							
	AP							

## OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

AQ		IBM Dossier #ARC920000094
AR		
AS		

EXAMINER <i>B. Smull</i>	DATE CONSIDERED <i>5/2/06</i>
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